## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10765772	CHERIAN, GABE
Examiner	Art Unit
HOA C NGUYEN	2841

SEARCHED						
Class	Subclass	Date	Examiner			
174	260,138G,259,263,361,255,256	5/10/06	HN			
361	743,767	5/10/06	HN			
Update search		5/11/07	HN			
Update search		1/3/08	HN			
Update search		6/3/08	HN			

SEARCH NOTES				
Search Notes	Date	Examiner		
East text search	5/10/06	HN		
Update search in 361/761,764,731,733,760,785-786	5/11/07	HN		
Update search	1/3/08	HN		
Update search	6/3/08	HN		
Consulted with Primary Examiner Randy W. Gibson with the regard to the	6/3/08	HN		
Applicant's arguments. After reviewing the case and the arguments, Randy suggested the case should be allowed.				

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
All	((substrate layer plane) and (array) and (attachment) and (pad land contact electrode) and (elongat\$3) and (direction) and (perpendicular) and (individual adj (ray line)) and (point)).clm.	6/4/08	HN		

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